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# Reduction and Agglomeration of Supported Metal Clusters Induced by High Flux X-ray Absorption Spectroscopy Measurements

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ABSTRACT: Supported metal clusters are widely used in catalysis for many important reactions. To understand the catalytic properties, *in-situ/operando* characterization techniques, such as X-ray absorption spectroscopy, provide essential details about the size, shape and chemical composition of the cluster and the nature of the active sites. New generation synchrotrons combined with focusing beamlines provide high flux density X-rays for improved detection sensitivity as well as higher time- and spatial- resolution. Understanding the effects of a high flux density X-ray beam on the catalyst during the actual measurement, whether XAS or other synchrotron-based techniques, is crucial. This is especially important for *in-situ* and *operando* studies where both the high flux density and reaction conditions can affect the catalyst structure. In this work we investigated the effect of the flux density on rhodium clusters supported on Al<sub>2</sub>O<sub>3</sub> at two different beamlines: National Synchrotron Light Source II beamline 08-ID and Stanford Synchrotron Radiation Light Source beamline 4-1. We show that the higher flux density at beamline 08-ID causes reduction of highly dispersed RhO<sub>x</sub>/Al<sub>2</sub>O<sub>3</sub> catalyst even at room temperature. Additionally, exposure to the higher flux density X-rays at beamline 08-ID during *in-situ* reduction results in significant agglomeration of the Rh clusters. The final size of Rh nanoparticles reduced at 310 °C is equivalent to particles formed after reduction at 600-650 °C in the absence of the beam. Significant beam induced reduction and agglomeration is also shown for Ni supported on beta zeolite during *in-situ* reduction at an intermediate flux density beamline 9-3 at SSRL, indicating that beam induced changes of heterogeneous catalysts could be common at intermediate and high flux density beamlines. We provide precautions and recommendations to detect and minimize beam damage during *in-situ/operando* X-ray absorption spectroscopy measurements.

## 1. INTRODUCTION

Supported metal nanoparticles are widely used to catalyze many chemical transformations. The size, shape and composition strongly affect the nanoparticles' catalytic properties making their characterization, especially *in-situ* and *operando*, essential to develop a more fundamental understanding of catalysis. Advances in imaging and spectroscopy techniques have led to an improved fundamental understanding of the important relationships between the catalytic properties and the structure of the metal clusters/nanoparticles<sup>1</sup>. Experimental techniques such as scanning/transmission electron microscopy (S/TEM) and X-ray absorption spectroscopy (XAS) are used to determine a catalyst's structure, elemental composition and oxidation state through a combination of imaging and spectroscopy. When performing these experiments the catalyst is exposed to both high energy and high dose electron and X-ray beams, which may have the deleterious effect of altering the catalyst structure.

S/TEM imaging is an inherently high spatial resolution imaging technique that can be combined with spectroscopy (energy dispersive X-ray spectroscopy and electron energy loss spectroscopy). The electron beam can induce radiation damage within the specimen which is determined by electron energy (or accelerating voltage) dose used during characterization. For example, it has been reported that a 400 keV electron beam causes small metal clusters, such as platinum and rhodium supported on silica and carbon, to agglomerate into large particles<sup>2-3</sup>. Moreover, nanocrystalline silver particles were observed to grow rapidly (from 15 nm to 2  $\mu\text{m}$ ) when exposed to electron beam irradiation<sup>4</sup>. Furthermore, intensive research confirmed the effect of the electron beam from transmission microscopy on supported gold clusters which cause rearrangement, reconstruction and agglomeration to form larger particles<sup>5-6</sup>. Due to these undesirable beams

induced effects, new techniques are currently being developed to image beam-sensitive materials: lower keV, lower dose and cryo-EM imaging conditions<sup>7-10</sup>.

For heterogeneous catalysts, X-ray beams used for XAS have not typically been associated with causing damage similar to that observed in electron microscopy. As the demand for *in-situ* and *operando* measurements increases along with the need for higher temporal resolution and lower detection limits, beamlines with higher flux (upwards of  $10^{12}$  photons/s) have been increasingly used for XAS measurements of heterogeneous catalysts. A higher flux allows for the detection of low concentration species and observing fast structural changes under *in-situ/operando* conditions. However, a higher X-ray flux, especially when focused to a small area of the sample (i.e. high flux density) can lead to undesirable structure and chemical changes that lead to the appearance of intermediates and structures not actually present during catalysis under the same conditions. Such X-ray induced changes are common and well documented for biological samples and homogeneous catalysts<sup>11-12</sup>. For instance, X-rays have been shown to induce reduction of metal complexes in solution<sup>12-14</sup> as well as nucleation, growth and agglomeration of nanoparticles<sup>15-18</sup>. Similarly, surface grafted Cu<sup>II</sup> organometallics on SiO<sub>2</sub> and Al<sub>2</sub>O<sub>3</sub> were easily reduced to Cu<sup>I</sup> in a high flux density X-ray beam while Cu<sup>II</sup> was stable in a non-focused beam (low flux density)<sup>19</sup>. However, while structural and chemical changes induced by high energy electron beams are well documented in S/TEM for heterogeneous catalysts; those effects have only been recently shown for XAS<sup>19</sup>. As the development of higher flux beamlines continues (e.g. so-called diffraction-limited 4<sup>th</sup> generation synchrotrons), beam effects are likely to become more common rather than being the exception. Unfortunately, most XAS studies of heterogeneous catalysts do not systematically check for beam effects or rarely report them. Therefore, a thorough study/analysis of the extent of beam effects on supported metal nanoparticles is needed to provide an

understanding of the damage that might result during *in-situ/operando* XAS measurements at high flux X-ray beamlines.

In this work we have studied the effect of X-ray flux density on the catalyst structure at two different beamlines; a wiggler side station (SSRL BL 4-1) and a damping wiggler station with a higher flux density (NSLS-II BL 08-ID). We support these studies with electron microscopy and H<sub>2</sub> chemisorption. Rhodium supported on alumina was used as a test case since Rh/Al<sub>2</sub>O<sub>3</sub> is a well-known catalyst for several important industrial applications, such as three-way catalyst used in automotive catalytic converters, which also has been extensively studied spectroscopically in the past few decades. We found that Rh clusters are very sensitive when exposed to a high X-ray flux density which leads to significant reduction and agglomeration. Using low X-ray flux density ( $\sim 10^{10}$  photons/sec/mm<sup>2</sup>) during *in-situ* measurements at SSRL BL 4-1, the Rh clusters remain small and the Rh-Rh coordination was consistent with the size obtained from *ex-situ* microscopy. However, using a higher X-ray flux density ( $\sim 10^{12}$  photons/sec/mm<sup>2</sup>) at NSLS-II BL 08-ID under otherwise similar *in-situ* conditions, the Rh-Rh coordination number increased and became similar to the coordination number for reduction at much higher temperature. The beam induced reduction and agglomeration appear to be more common than previously known. *In-situ* reduction of Ni supported on beta zeolite at an intermediate flux density beamline (SSRL BL 9-3,  $\sim 10^{11}$  photons/sec/mm<sup>2</sup>) resulted in significant reduction and agglomeration of Ni compared to measurements without beam exposure during reduction. The results indicate that *in-situ/operando* catalyst studies using high flux beamlines need to be carefully designed in order to eliminate/reduce beam damage.

## 2. EXPERIMENTAL METHODS

### 2.1 Synthesis and pretreatment

The Rh/Al<sub>2</sub>O<sub>3</sub> catalyst with a nominal loading of 0.5 wt% was prepared by strong electrostatic adsorption. The  $\gamma$ -Al<sub>2</sub>O<sub>3</sub> support (BET surface area 220 m<sup>2</sup>/g) was obtained by calcining Boehmite (CATAPAL B from Sasol) at 600 °C for 3 hours before catalyst synthesis. Two grams of  $\gamma$ -Al<sub>2</sub>O<sub>3</sub> support was added to 1 L of deionized water at room temperature while stirring (600 rpm). A 300  $\mu$ L solution of 37 wt% HCl was slowly added to adjust the pH to 3. A Rh solution (20 mL) was prepared by dissolving about 0.01 g of RhCl<sub>3</sub>·xH<sub>2</sub>O (Sigma Aldrich 450286, Lot # MKCH3679) in deionized water and a suitable amount of HCl to maintain the pH at 3. The Rh solution was then added to the 1 L Al<sub>2</sub>O<sub>3</sub> solution at room temperature while stirring at 600 rpm for 4 hours. The solution was then filtered to separate the solid (catalyst) from the liquid. The catalyst was dried overnight at 80 °C and for 1 hour at 100 °C for 1 hour then calcined at 450 °C with ramp rate of 5 °C/min and held at 450 °C for 4 hours. The actual Rh loading was found to be 0.3 wt% by measuring the Rh concentration in the initial and filtered solutions using inductively coupled plasma atomic emission spectroscopy (ICP-AES). All the reported results were obtained using the same batch of the catalyst to eliminate any possible variations between batches. The catalyst pretreatment was identical for all the experiments and started with an oxidation step in 20% O<sub>2</sub> (99.999% Airgas) balanced with He (99.999% Airgas) at 310 °C (10 °C/min) for 30 min then the catalyst was reduced in 20% H<sub>2</sub> (99.999% Airgas) balanced with He (99.999% Airgas) at 310 °C or 650 °C for 2 hours. The total flowrate was 50 sccm during the pretreatment.

NH<sub>4</sub>-[Al]-Beta (Si/Al = 19, Zeolyst CP814C) was dealuminated by mixing NH<sub>4</sub>-[Al]-Beta in 13 M HNO<sub>3</sub> for 16 h at 80°C. After dealumination the zeolite was washed with water and then calcined at 500 °C in 10% O<sub>2</sub> for 6 hours, with a hold for 1 hour at 120 °C and ramp rate of



2 °C/min then transferred to an Ar filled glovebox. Ni was deposited by mixing [DeAl]-Beta with Ni(acac)<sub>2</sub> (STREM Chemicals) in dried, de-oxygenated n-pentane for 24 hours on a Schlenk line to exclude moisture and O<sub>2</sub>. The solvent was then evacuated for 24 hours and the resulting powder was calcined at 600 °C in 10% O<sub>2</sub> for 6 hours, with a 1 hour hold at 120 °C with a ramp rate of 2 °C/min.

### 2.3 X-ray absorption spectroscopy

The *in-situ* X-ray absorption spectroscopy experiments were performed at the Stanford Synchrotron Radiation Light Source (SSRL) beamline 4-1 (BL 4-1), beamline 9-3 (BL 9-3) and at the National Synchrotron Light Source II (NSLS-II) Inner Shell Spectroscopy (ISS) beamline 08-ID (BL 08-ID). A comparison of the flux and beam size of the beamlines is summarized in Table 1. Details of both beamlines and flow cells used for the measurements are described below.

SSRL BL 4-1 is a 20-pole, 2 - Tesla wiggler side station with vertically collimating mirror. The photon flux is nominally reported to be  $2 \times 10^{12}$  photon/s<sup>20</sup>. The flux was measured directly with the Ar ion chamber in order to estimate the flux at the Rh K-edge (23,220 eV). Using the Si [220],  $\phi=0$ , the measured flux for the beam size used in the experiments (0.25 mm  $\times$  4 mm, vertical  $\times$  horizontal) was  $3.2 \times 10^{10}$  photons/s. The catalyst was loaded into a 2.8 mm i.d. (3.0 mm o.d.) quartz tube with a bed length of 10 mm (approximately 30 mg). Two coil heaters approximately 2 mm, one above and the other below, were used to heat the catalyst. Kapton film was put around the setup in order to create a layer of stagnant air for insulation. The temperature inside the reactor was measured via a thermocouple inserted through the reactor tube immediately downstream of the catalyst, only being separated by a thin layer of quartz wool. The reactor has been more thoroughly described in previous work<sup>21</sup>.

SSRL BL 9-3 is a 16-pole, 2-Tesla Wiggler, 2 mrad acceptance, with vertically collimating M0 mirror and cylindrically bent Rh coated M1 focusing mirror. The flux is nominally reported to be  $2 \times 10^{12}$  photon/s. The flux was measured directly with a nitrogen filled ion chamber at the Ni K-edge (8400 eV). Using the Si [220],  $\varphi=0$ , the measured flux for the beam size used in the experiments (1.0 mm  $\times$  3 mm, vertical  $\times$  horizontal) was  $3.22 \times 10^{11}$  photons/s (flux density of  $1.1 \times 10^{11}$  photons/s/mm<sup>2</sup>). The catalyst was loaded into a 3.0 mm o.d. Kapton tube with a bed length of 10 mm (approximately 40 mg). The experiment was conducted using the same reactor as at BL 4-1, above.

NLS-II BL 08-ID has a damping wiggler source that provides high flux photon ( $10^{14}$  photon/s at 10 keV at full accelerator current) with a 1 mm  $\times$  1 mm spot size<sup>22</sup>. The ion chamber response was calibrated using SYDOR diamond detector<sup>23</sup>, and at Rh edge the flux is  $4 \times 10^{12}$  photons/s. 100 mg of catalyst was loaded into a custom built 4 mm i.d. glassy carbon tube. An approximately 1"  $\times$  3"  $\times$  6" stainless steel block with a vertical bore for the reactor and horizontal rectangular bore through the side and surrounded by approximately 1" ceramic insulation was used as a reactor. The temperature inside the reactor was measured via a thermocouple inserted through the reactor tube immediately downstream of the catalyst, only being separated by a thin layer of quartz wool. The reactor has been more thoroughly described in previous work<sup>24</sup>.

**Table 1:** Details of the beamlines at SSRL and NSLS-II.

<b>BEAMLINE</b>	<b>SSRL BL 4-1 WIGGLER SIDE STATION</b>	<b>NSLS-II BL 08-ID DAMPING WIGGLER STATION</b>	<b>SSRL BL 9-3 2-TESLA WIGGLER</b>
<b>FLUX at 23,220 eV (photons/s)</b>	$3.2 \times 10^{10}$	$4 \times 10^{12}$	$3.22 \times 10^{11*}$
<b>BEAM SIZE (mm × mm)</b>	0.25×4	1×1	1×3
<b>FLUX DENSITY (photons/s/mm<sup>2</sup>)</b>	$3.2 \times 10^{10}$	$4 \times 10^{12}$	$1.1 \times 10^{11}$

\* Flux measured at 8,400 eV.

Two experiments for the Rh/Al<sub>2</sub>O<sub>3</sub> catalyst were conducted at each beamline, SSRL BL 4-1 and NSLS-II BL 08-ID. The experimental conditions are summarized in Table 2 and described in more details next. At SSRL BL 4-1 for the 310 °C reduced catalyst, EXAFS scans were taken of the fresh, calcined sample. The sample was then oxidized in 16% O<sub>2</sub> (balance He) for 10 minutes at 310 °C (ramp rate of 20 °C/min up and 100 °C/min down). The sample was then reduced in 20% H<sub>2</sub> (balance He) for 2 hours at 310 °C (ramp rate of 10 °C/min up and 100 °C/min down). During the reduction, the catalyst was exposed to the beam. For the 650 °C reduced catalyst, the sample was already reduced *ex-situ* at 650 °C then re-reduced *in-situ* in 20% H<sub>2</sub> (balance He) for 45 minutes at 650 °C (ramp rate of 10 °C/min up and 100 °C/min down). During the reduction, the catalyst was exposed to the beam.

At NSLS-II BL 08-ID, for the 310 °C reduced catalyst, EXAFS scans were taken of the fresh, calcined sample. The sample was then oxidized in 20% O<sub>2</sub> (balance He) for 30 minutes at 310 °C (ramp rate of 10 °C/min up and ~10 °C/min down limited by convective cooling using a fan). EXAFS scans were taken of the sample. The sample was then reduced in 20% H<sub>2</sub> (balance He) for

1 hour at 310 °C (ramp rate of 10 °C/min up and ~10 °C/min down limited by convective cooling). During the reduction, the catalyst was exposed to the beam. After reduction, EXAFS scans were taken of the sample in H<sub>2</sub>. For the second experiment, EXAFS scans were taken of the fresh, calcined sample. The sample was then oxidized in 20% O<sub>2</sub> (balance He) for 10 minutes at 200 °C (ramp rate of 10 °C/min up and ~10 °C/min down limited by convective cooling). EXAFS scans were taken of the sample. The sample was then reduced in 20% H<sub>2</sub> (balance He) for 1 hour at 200 °C (ramp rate of 10 °C/min up and ~5 °C/min down limited by convective cooling). During the reduction, the catalyst was not exposed to the beam. After reduction EXAFS scans were taken of the sample in H<sub>2</sub>.

**Table 2:** Summary of the *in-situ* experimental conditions used for the 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> catalyst. At both beamlines, ultra-high purity (99.999%) O<sub>2</sub>, H<sub>2</sub>, CO, and He were blended to get the gas concentrations mentioned using a mass flow control board available at each location.

<b>EXPERIMENT</b>	<b>SSRL BL 4-1 310 °C</b>	<b>SSRL BL 4-1 650 °C</b>	<b>NSLS-II BL 08-ID 310 °C</b>	<b>NSLS-II BL 08-ID 200 °C</b>
<b>FLUX at 23,220 eV (photons/s)</b>	3.2×10 <sup>10</sup>	3.2×10 <sup>10</sup>	4×10 <sup>12</sup>	4×10 <sup>12</sup>
<b>BEAM SIZE (mm × mm)</b>	0.25×4	0.25×4	1×1	1×1
<b>OXIDATION</b>	16% O <sub>2</sub> 310 °C 10 minutes	None	20% O <sub>2</sub> 310 °C 30 minutes	20% O <sub>2</sub> 200 °C 10 minutes
<b>REDUCTION</b>	20% H <sub>2</sub> 310 °C 2 hours	20% H <sub>2</sub> 650 °C 45 minutes	20% H <sub>2</sub> 310 °C 1 hour	20% H <sub>2</sub> 200 °C 1 hour
<b>BEAM ON DURING REDUCTION</b>	Yes	Yes	Yes	No

The parameters for the respective measurements were: a) Scan time was ~11 minutes and ~40 seconds (including time for the monochromator to reset in between scans) at SSRL and NSLS-II, respectively. b) At both beamlines data were collected in both transmission and fluorescence modes, however only the fluorescence data is used in our analysis. c) A Passivated Implanted Planar Silicon (PIPS) detector mounted at a 90° angle from the beam was used for fluorescence detection at both beamlines. At BL 4-1 transmission data were collected with ionization chambers filled with Ar at 1 atm. While at BL08-ID ionization chambers filled with a mixture of He and N<sub>2</sub> (2 parts He, 5 parts N<sub>2</sub>) at 1 atm. These detectors were located upstream of the sample, between the sample and the reference foil, and downstream of the reference foil.

The details of *in-situ* experiments on Ni/beta zeolite at SSRL BL 9-3 are provided in the supporting information.

Data processing and analysis, for the X-ray absorption near edge and the extended X-ray absorption fine structure (XANES and EXAFS), were performed using Athena and Artemis programs of the Demeter data analysis package<sup>25-26</sup>. After the normalization of the absorption coefficient, the smooth atomic background was subtracted using the AUTOBKG code in Athena to obtain  $\chi(k)$  (where  $k$  is the photoelectron wave number). The theoretical EXAFS signal for Rh-O and Rh-Rh scattering paths were constructed using the FEFF6<sup>27</sup> code using the crystal structure of Rh<sub>2</sub>O<sub>3</sub> and Rh metal, respectively. The theoretical EXAFS signals were fitted to the data in  $r$ -space using Artemis by varying the coordination numbers of the single scattering paths, the effective scattering lengths, the bond length disorder and the correction to the threshold energy,  $\Delta E_0$ , for each path; Rh-O and Rh-Rh.  $S_0^2$  (the passive electron reduction factor) was obtained by first analyzing the first shell of the Rh foil spectrum, and the best fit value ( $0.85 \pm 0.04$  for data collected at SSRL BL 4-1 and  $0.84 \pm 0.05$  for data collected at NSLS-II BL 08-ID) was fixed for the fit. The  $k$ -range

used for the Fourier transform of  $\chi(k)$  was 3-12.5  $\text{\AA}^{-1}$  (3-14  $\text{\AA}^{-1}$  for the reduced catalysts) and the r-range for fitting was 1.2-3.1  $\text{\AA}$ . The best parameters fit using k-weights of 1, 2, and 3 (simultaneously) in Artemis are reported, however, the results were similar to those using only a k-weight of 2. Additionally, the k-range did not have a significant effect on the best fit values of the model fit but did affect their uncertainties.

## 2.4 Aberration corrected scanning transmission electron microscopy

Aberration-corrected scanning transmission electron microscopy was used to measure the particle size distribution of the 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> catalyst after reduction in H<sub>2</sub> at 310 °C and 650 °C. The calcined catalyst was pretreated first in 20 kPa O<sub>2</sub> (balance He at 95 sccm total flowrate) at 310 °C with ramp rate 10 °C/min and held for 1 hour then reduced using H<sub>2</sub> at 20 kPa (balanced with He) at 310 °C with ramp rate 10 °C/min and held for 2 hours. The reduced catalysts were characterized *ex-situ* using an aberration corrected Nion UltraSTEM operating at 100 keV and on an aberration corrected JEOL JEM-ARM200F at an acceleration voltage of 200 kV. We measured the diameter of about 100 particles using the ImageJ software where both the size measurements of the particles and counting the Rh single atoms was done manually<sup>28</sup>. The number, surface and volume average particle sizes (diameter) were calculated as  $\sum_i^N \frac{n_i d_i}{n_i}$ ,  $\sum_i^N \frac{n_i d_i^2}{n_i d_i}$  and  $\sum_i^N \frac{n_i d_i^3}{n_i d_i^2}$ , respectively<sup>29</sup>.

## 2.5 H<sub>2</sub> volumetric chemisorption

Volumetric H<sub>2</sub> chemisorption was carried out using Micromeritics 3Flex surface characterization analyzer. 0.5 g of 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> was used for the H<sub>2</sub> volumetric chemisorption. The catalyst (pellet size between 150  $\mu\text{m}$  to 250  $\mu\text{m}$ ) was packed in a quartz sample holder. The catalyst was pretreated with an oxidation step at 310 °C and a reduction step at 310 °C

or 650 °C. The pretreatment was performed in static mode where the oxidation step start was adding pure O<sub>2</sub> at room temperature and heated up to 310 °C with ramp rate 10 °C/min and held for 30 min followed by evacuation at 310 °C for 30 min. This procedure of adding oxygen for 30 min then evacuation was repeated three times. The sample was then evacuated at 310 °C for 30 mins and cooled to 35 °C. The reduction step started with adding pure H<sub>2</sub> at 35 °C and was then heated up to 310 °C or 650 °C with ramp rate 10 °C/min and held for 30 min followed by an evacuation step at 310 °C or 650 °C for 30 minutes. Adding pure hydrogen and holding for 30 min followed by an evacuation was repeated 4 times for a total time of 2 hours. After the pretreatment, the sample was evacuated at 310 °C or 650 °C for 30 minutes, then cooled at 35 °C while still under vacuum before the H<sub>2</sub> volumetric chemisorption. Two H<sub>2</sub> chemisorption isotherms were performed with an evacuation step between them to remove the physisorbed H<sub>2</sub>. The difference between the first and second isotherms was used to calculate the quantity of chemisorbed H<sub>2</sub> and H:Rh ratio.

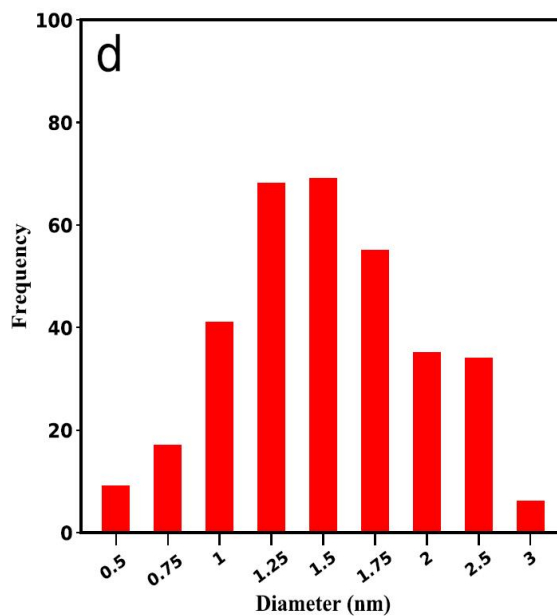
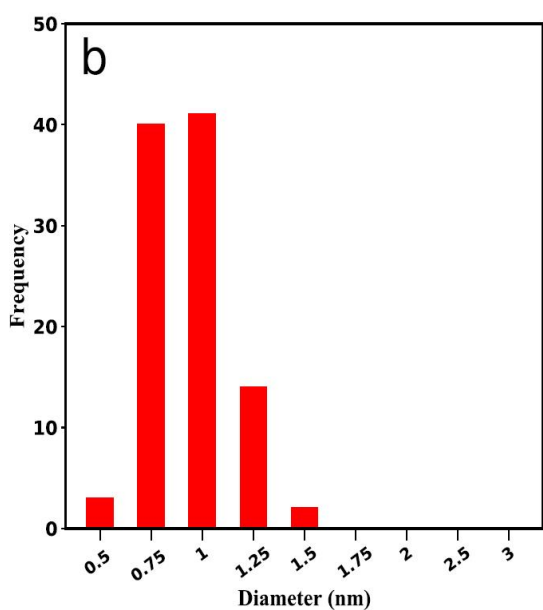
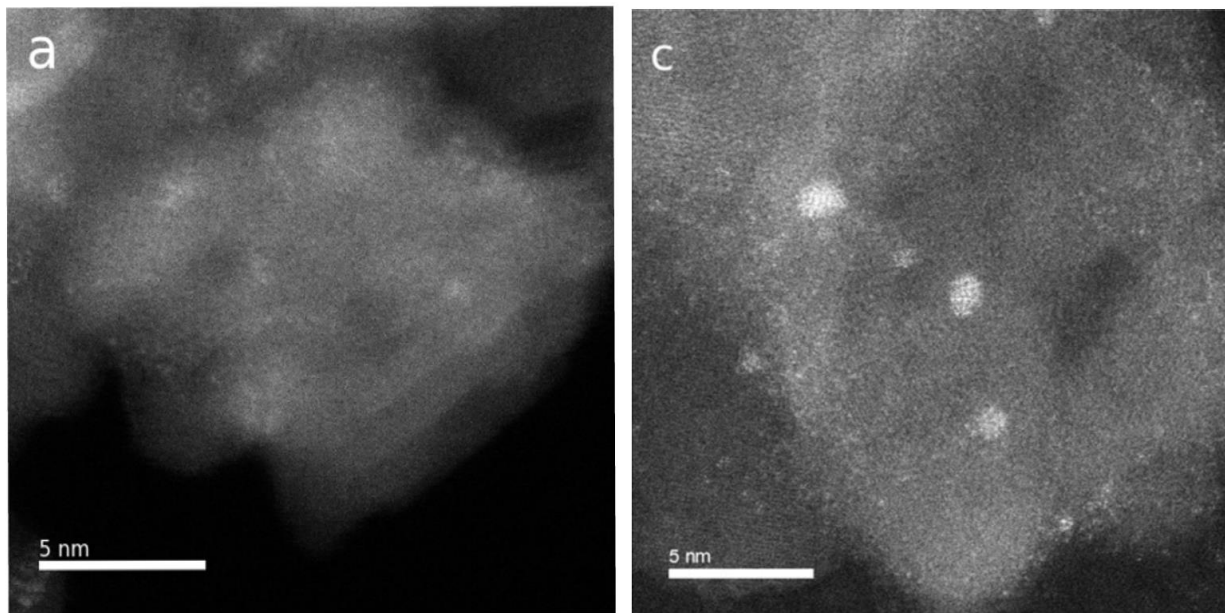
### 3. RESULTS AND DISCUSSION

#### 3.1 Rh size distribution after *ex-situ* reduction and H<sub>2</sub> volumetric chemisorption

Figure 1a shows HAADF-STEM image for the 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> catalyst after reduction at 310 °C. The image shows mostly Rh subnanometer clusters and small nanoparticles with a narrow size distribution ranging from 0.5-1.2 nm along with a few Rh single atoms as shown in Figure 1b. The number-average, surface-average and volume average-diameters were calculated to be 0.8, 0.85 and 0.9 nm, respectively. The small size is due to the low Rh loading and low reduction temperature which is also consistent with previous reports that Rh/Al<sub>2</sub>O<sub>3</sub> prepared using RhCl<sub>3</sub> as a precursor can form uniform particles (ranging from 0.3 nm to 1.7 nm) even with reduction temperatures of 500 °C<sup>30</sup>. On the other hand, when the catalyst was reduced at 650 °C, the particle

size increased, as shown in the STEM image in Figure 1c and the size distribution in Figure 1d. The number-average, surface-average and volume average diameters were calculated to be 1.4, 1.5 and 1.6 nm, respectively. The H:Rh ratio from H<sub>2</sub> chemisorption on the 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> catalyst reduced at 310 and 650 °C was 0.85 and 0.62, respectively which are consistent with the sizes measured from STEM.



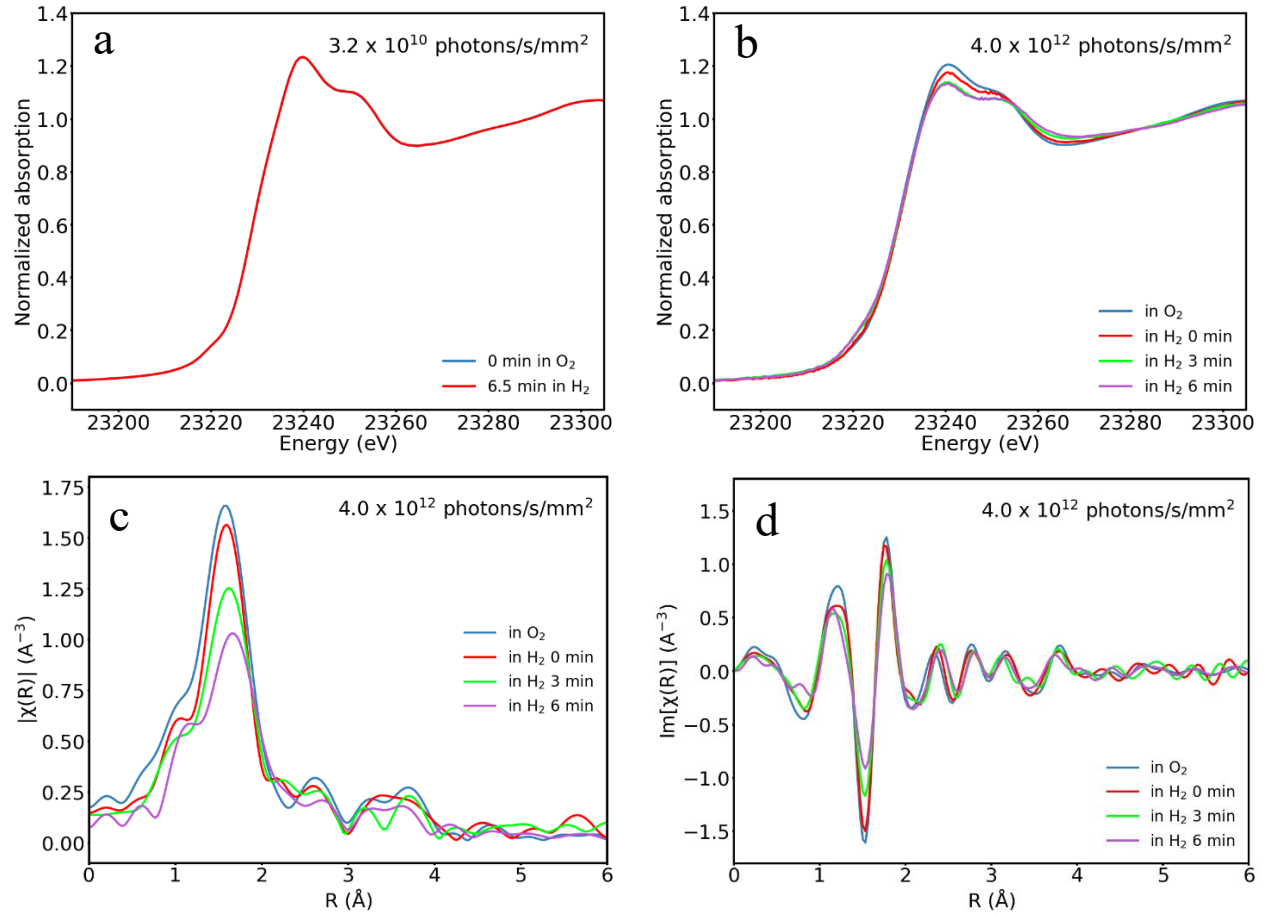


**Figure 1:** (a) and (b) STEM images for 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> after reduction at 310 °C and 650 °C. (c) and (d) are the particle size distributions of the reduced catalysts at 310 °C (created by measuring the diameter of 100 particles from 20 different images) and 650 °C (created by measuring the diameter of 320 particles from over 40 images)

### 3.2 Effect of the X-ray beam on Rh oxidation state at room temperature

Before performing *in-situ* reduction experiments at elevated temperatures, we started by investigating the effect of the X-ray flux density on the state of the calcined Rh/Al<sub>2</sub>O<sub>3</sub> catalyst at room temperature. The XANES and EXAFS spectra for the calcined 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> were similar at both beamlines, and the Rh-O coordination number was 6.5±1.5 (Table S1). No changes in the spectra were observed during the 10-30 minutes oxidation step at 310 °C at both beamlines (Figure S1). Figures 2a and 2b show time resolved Rh K-edge XANES of the calcined 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> catalyst at room temperature under 20% H<sub>2</sub> (balance He) for experiments performed at SSRL BL 4-1 and NSLS-II BL 08-ID, respectively. For the SSRL BL 4-1 experiment, no changes were observed as shown in Figure 2a. On the other hand, the higher flux density at NSLS-II BL 08-ID resulted in an observable decrease of the white line intensity over time under H<sub>2</sub> as shown in Figure 2b. The decrease in the white line intensity and the formation of isosbestic points at 23,255 and 23,285 eV are associated with partial reduction of rhodium oxide (Rh<sup>+3</sup>) into Rh metal (Rh<sup>0</sup>)<sup>30-31</sup>. A linear combination fit of the XANES spectra using Rh foil and the calcined catalyst as standards show that Rh is ~29% reduced at room temperature after 6 min exposure to the beam at NSLS-II BL 08-ID. In addition, the EXAFS spectra in Figures 2c and 2d show a decrease in the intensity of the Rh-O peak (at ~1.5 Å) and the corresponding Rh-O coordination number decreased from 6.5±1.5 in O<sub>2</sub> to 5.0±1.5 after 6 minutes in H<sub>2</sub> (Table S1). The EXAFS results indicate a partial reduction of Rh at room temperature which is consistent with the XANES results in Figure 2b. It is well known that reduction of highly dispersed RhO<sub>x</sub> supported on Al<sub>2</sub>O<sub>3</sub> does not start until ~150 °C<sup>32-33</sup>. Our temperature programmed reduction results (Figure S2) showed that a temperature of 100-120 °C is required to start the reduction of Rh in the calcined 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> catalyst. At SSRL BL 4-1, the beam did not affect the oxidation state of Rh at room temperature

regardless of gas environment ( $\text{H}_2$  or  $\text{O}_2$ ). Therefore, the partial reduction of  $\text{Rh}^{3+}$  in  $\text{H}_2$  at NSLS-II BL 08-ID is indicative of a beam effect caused by the high flux density even within 6 min of exposure to the beam.



**Figure 2:** Rh K-edge X-ray absorption spectroscopy for 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> at room temperature under a flow of 20% H<sub>2</sub> (balanced with He). (a) XANES at SSRL BL 4-1 ( $3.2 \times 10^{10}$  photons/s/mm<sup>2</sup>), (b) XANES at NSLS-II BL 08-ID ( $4 \times 10^{12}$  photons/s/mm<sup>2</sup>), (c) EXAFS magnitude and (d) imaginary parts of the Fourier transformed  $k^2$ -weighted  $\chi(k)$  data,  $\Delta k = 3\text{-}13 \text{ \AA}^{-1}$  for the experiment at NSLS-II BL 08-ID ( $4 \times 10^{12}$  photons/s/mm<sup>2</sup>).

### 3.4 Effect of the X-ray beam on average Rh cluster size resulting from *in-situ* reduction

In addition to the observed changes at room temperature as a result of the high beam density at NSLS-II 08-ID, we also observed significant changes during and after reduction compared to the same experiment performed at SSRL BL 4-1. Linear combination fitting of the *in-situ* XANES during reduction (Figure S3) shows that Rh is significantly more reduced at the same temperature at NSLS-II BL 08-ID. Figure 3 shows a comparison of the EXAFS spectra at SSRL BL 4-1 and NSLS-II 08-ID after reduction at 310 °C for 2 hours. It can be seen that there is significantly higher intensity for the Rh-Rh scattering peak (at  $\sim 2.6$  Å) from the NSLS-II BL 08-ID experiment compared to that at SSRL BL 4-1, indicating a larger average Rh cluster size. Indeed, the EXAFS modeling results (Table 3) show that the Rh-Rh coordination numbers were  $4.0 \pm 0.5$  and  $6.2 \pm 0.8$  at SSRL BL 4-1 and NSLS-II 08-ID, respectively. Assuming hemispherical shaped clusters<sup>34</sup>, the coordination numbers of  $4.0 \pm 0.5$  and  $6.2 \pm 0.8$  correspond to an average diameter of  $\sim 0.5$  nm and 1.0 nm at SSRL BL 4-1 and NSLS-II BL 08-ID, respectively. The number-average diameter from HAADF-STEM after reduction at 310 °C was 0.8 nm which is larger than the estimated size from EXAFS at SSRL BL 4-1. The presence of Rh single atoms in the catalyst after reduction at 310 °C, as shown in Figure 1, is likely the cause of the lower than expected Rh-Rh coordination number. The Rh-O coordination number of 0.4 is also consistent with Rh single atoms and Rh atoms in small clusters, which are coordinated with oxygens from the support. In principle, if the percentage of single atoms is known, the Rh-Rh coordination can be corrected to reflect the clusters only. However, due to the low number of single atoms and clusters in the HAADF-STEM images, the estimated percentage of single atoms (5%) is likely underestimated and could not be used to calculate the actual Rh-Rh coordination number for the nanoparticles. For the experiment at NSLS-II BL 08-ID, including Rh-O scattering path in the EXAFS model was not necessary for the

best fit, which is consistent with the larger Rh size. It is clear from the *in-situ* XANES and EXAFS results that the higher flux density at NSLS-II BL 08-ID compared to SSRL BL 4-1 causes higher extent of reduction at lower temperature and agglomeration of Rh during reduction. This can be seen from the *in-situ* XANES spectra at 200 °C in Figure S4 and from the results of the linear combination fits of the *in-situ* XANES spectra in Figure S3, which shows more reduction at all temperatures at NSLS-II BL 08-ID than at SSRL BL 4-1. Furthermore, Figure S5 compares the *in-situ* XANES spectra at 100 and 200 °C to the spectrum collected after reduction at 200 °C without exposure to the beam. The results in Figure S5 show that more reduction occurs in the beam at NSLS-II BL 08-ID while heating to 200 °C than after 2 hours reduction at 200 °C without exposure to the beam. What is remarkable is that the EXAFS results at NSLS-II BL 08-ID for reduction at 310 °C were similar to those from SSRL BL 4-1 after reduction at 650 °C as shown in Table 3 and Figure 3. This is very surprising and shows the large extent a high flux beam can affect a catalyst during *in-situ* experiments.

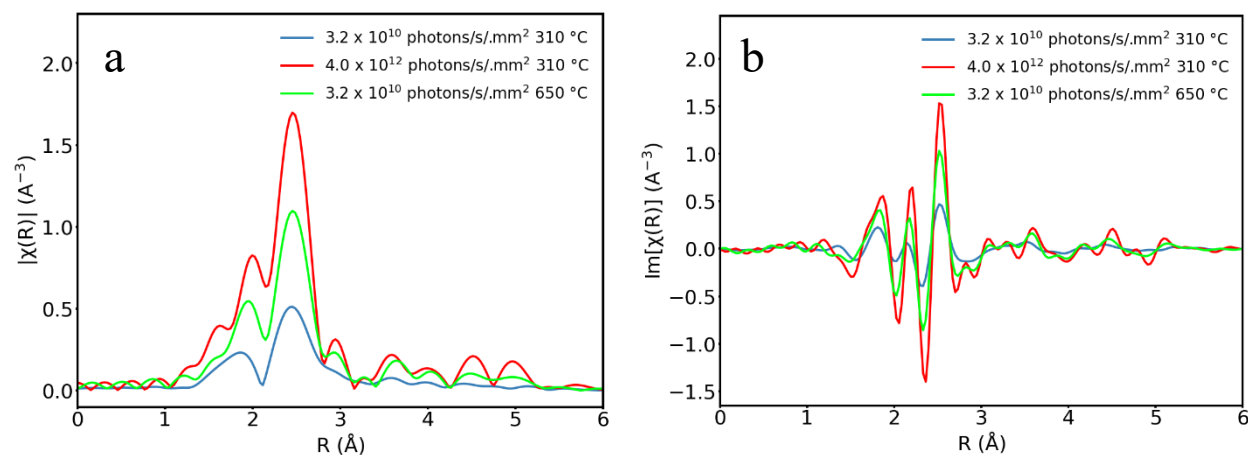
**Table 3:** Summary of the EXAFS modeling parameters for 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> after *in-situ* reduction at SSRL BL 4-1 and NSLS-II BL 08-ID. A comparison between the fits and data is provided in Figure S6.

Beamline	SSRL BL 4-1	SSRL BL 4-1	SSRL BL 4-1	NSLS-II BL 08-ID
Flux (photon/s)	3.2×10 <sup>10</sup>	3.2×10 <sup>10</sup>	3.2×10 <sup>10</sup>	4×10 <sup>12</sup>
Beam size (height × width, mm × mm)	0.25×4	0.25×4	0.25×4	1×1
Flux density (photon/s/mm <sup>2</sup> )	3.2×10 <sup>10</sup>	3.2×10 <sup>10</sup>	3.2×10 <sup>10</sup>	4×10 <sup>12</sup>
Reduction temperature (°C)	310	650 <sup>a</sup>	650	310
$N_{Rh-Rh}$	4.0±0.5	5.3±0.6 <sup>a</sup>	5.6±0.4	6.2±0.8
$N_{Rh-O}$	0.4±0.2	0.2±0.3		-
$R_{Rh-Rh}$ (Å)	2.655±0.008	2.663±0.008	2.662±0.005	2.677±0.005
$R_{Rh-O}$ (Å)	2.11±0.04	2.16±0.05		-
$\sigma_{Rh-Rh}^2 \times 10^3$ (Å <sup>2</sup> )	12±1	8±1	9±1	6±1
$\sigma_{Rh-O}^2 \times 10^3$ (Å <sup>2</sup> )	3±5	1±8		
$\Delta E_{0 Rh-Rh}$ (eV)	1.5±0.8	4.0±0.7	3.6±0.6	2.7±0.9
$\Delta E_{0 Rh-O}$ (eV)	6±6	10 <sup>a</sup>		
Reduced $\chi^2$	281	310	277	1482
R-factor	0.0031	0.005	0.006	0.010

<sup>a</sup> Including a Rh-O scattering path for the Rh/Al<sub>2</sub>O<sub>3</sub> catalyst reduced at 650 °C had a negligible effect on the fit and especially the Rh-Rh coordination number.

<sup>b</sup> fixed during the fit

Notation: N, coordination number of absorber-backscatterer pair; R, radial absorber-backscatterer distance;  $\sigma^2$ , the mean square displacement of the half-path length and represents the stiffness of the bond for a single scattering path,  $\Delta E_0$ , correction to the threshold energy.

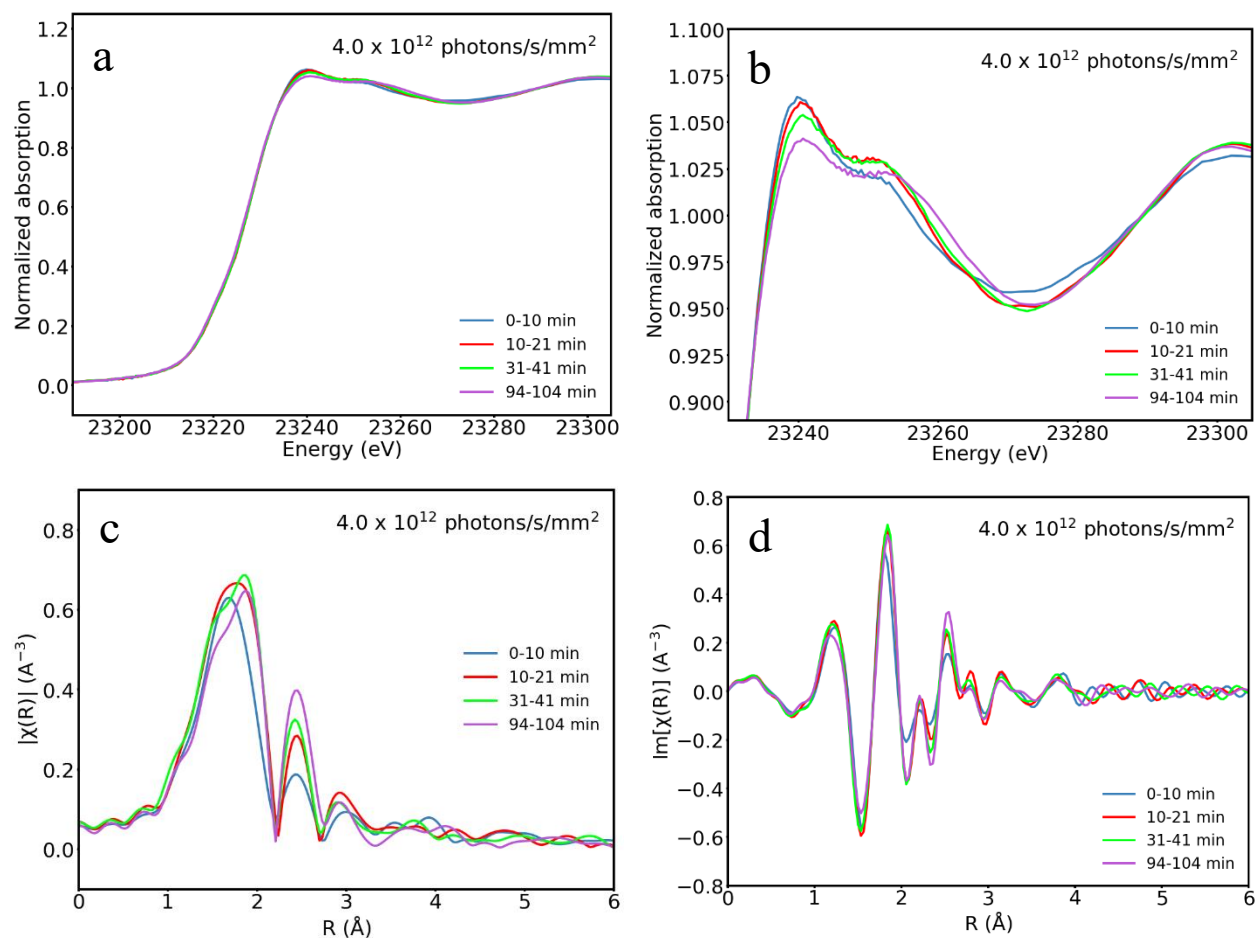


**Figure 3:** Rh K-edge X-ray absorption spectroscopy for 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> after reduction at 310 and 650 °C. The spectra are labelled by the beamline flux density, NSLS-II BL 08-ID ( $4 \times 10^{12}$  photons/s/mm<sup>2</sup>) and SSRL BL 4-1 ( $3.2 \times 10^{10}$  photons/s/mm<sup>2</sup>). The spectra were collected in H<sub>2</sub> at room temperature. (a) EXAFS magnitude and (d) imaginary part of the Fourier transformed  $k^2$ -weighted  $\chi(k)$  data,  $\Delta k = 3\text{-}13 \text{\AA}^{-1}$ .  $k$ -space data is shown in Figure S7.

### 3.5 Effect of the X-ray beam at NSLS-II BL 08-ID on an *ex-situ* reduced catalyst

*In-situ/operando* characterization of a catalyst provides invaluable information to help identify the structure/active sites and to understand the reaction mechanism<sup>35-37</sup>. However, *in-situ/operando* X-ray absorption measurements can take hours (reduction, different reaction conditions, etc.) to perform while the catalyst is exposed to the X-ray beam. The long exposure to the X-ray beam can have a significant effect on the catalyst structure as seen from the results in Figure 3 and Table 3. Therefore, we also investigated the effect of the high flux density at NSLS-II BL 08-ID on the 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> catalyst after *ex-situ* reduction at 200 °C, i.e. without exposure to the X-ray beam to avoid any beam damage during reduction. We chose a reduction temperature of 200 °C because Rh would be mostly present as isolated single atoms with some small clusters which are likely more sensitive to the beam. The time resolved XANES spectra in Figures 4a,b show a decrease in the Rh while line intensity from about 0.5 min to 104 min

accompanied by an increase in the Rh-Rh peak intensity in the corresponding EXAFS spectra (Figures 4c,d) and an increase in the Rh-Rh coordination number from 0.4 to 1.6 (Table S2). The absence of isosbestic points in the XANES spectra (Figures 4a,b) suggests the formation of an intermediate species between Rh single atoms and reduced Rh clusters<sup>38-39</sup>. We note that the effect of the beam on the catalyst reduced at 200 °C was observed after longer exposure (10-100 min, Figure 4) compared to the calcined sample (2-6 min in Figure 1b) indicating a synergistic effect of the temperature, H<sub>2</sub> (gas environment), and the X-ray beam.



**Figure 4:** Rh K-edge X-ray absorption spectroscopy for 0.3 wt% Rh/Al<sub>2</sub>O<sub>3</sub> after reduction at 200 °C at NSLS-II BL 08-ID (4 × 10<sup>12</sup> photons/s/mm<sup>2</sup>). (a), (b) XANES, (c) EXAFS magnitude and (d)



imaginary part of the transformed  $k^2$ -weighted  $\chi(k)$  data,  $\Delta k = 3\text{-}12 \text{ \AA}^{-1}$ . The catalyst was not exposed to the beam during reduction. All spectra were collected at room temperature.

Despite the advantages of using high flux X-ray beams for *in-situ* measurements on understanding the effect of reduction and reaction conditions on the catalyst structure, the beam can cause undesirable changes that can lead to misleading results. We show that a metal supported catalyst such as Rh/Al<sub>2</sub>O<sub>3</sub> can be easily damaged by high-flux density X-rays during *in-situ* XAS measurements. We note that the flux density needed to cause damage to a catalyst is relative and likely metal and support dependent. For example, for Ni supported on zeolite beta, we observed significant reduction and agglomeration by exposure to the beam during *in-situ* reduction (Figure S8) at an intermediate flux density beamline, SSRL BL 9-3 ( $1.1 \times 10^{11}$  photons/s/mm<sup>2</sup>). The linear combination fits of the XANES spectra (Figure S8) show that exposure to the beam resulted in much higher extent of reduction (~96%) and formation of Ni nanoparticles compared with ~57% reduction for the portion of the sample not exposed to the beam.

It has been proposed that the mechanism for X-ray-induced reduction of metal complexes in solution is caused by solvated electrons produced by H<sub>2</sub>O radiolysis and/or caused by ligand desorption<sup>15, 41-42</sup>. For Rh/Al<sub>2</sub>O<sub>3</sub>, as heterogenous catalyst in a gas environment, the mechanism of X-ray beam-induced reduction and agglomeration could be due to local heating effect or by secondary electron generated by the interaction of the X-rays with the rhodium atoms. Pagliero, et al.<sup>43</sup> showed that 17 keV X-ray nanobeam with flux density of  $1.4 \times 10^{19}$  photons/s/mm<sup>2</sup> (photon flux  $1.9 \times 10^{11} \text{ s}^{-1}$  and beam size 117 nm  $\times$  116 nm), caused changes in the oxygen doping levels in Bi<sub>2</sub>Sr<sub>2</sub>CaCu<sub>2</sub>O<sub>8+ $\delta$</sub>  (Bi-2212) superconducting single crystal. Using a finite element model, they found that radiation heating by the final phonon-assisted decay of the power delivered to the crystal by the X-ray nanobeam only increased temperature by a maximum of ~23.6 K. They

suggested that the oxygen doping change in the Bi-2212 superconductor is due to secondary electrons<sup>43</sup>. In addition, other reports also confirm that the X-ray-induced effects due to heating the sample are unlikely unless very high flux densities  $\sim 10^{22}$  photons/s/mm<sup>2</sup> are used<sup>44</sup>. In our Rh/Al<sub>2</sub>O<sub>3</sub> experiments, the beam-induced reduction and agglomeration at NSLS-II BL 08-ID was equivalent to overheating the sample by  $\sim 350$  °C (Figure 3). However, the flux density at NSLS-II BL 08-ID of  $4 \times 10^{12}$  photons/s/mm<sup>2</sup> is orders of magnitude lower than the values needed to cause significant heating. Therefore, we propose that the main source of X-ray beam-induced reduction and agglomeration of Rh is likely secondary electrons. Specifically, secondary electrons on the metal surface can generate reactive adsorbed species (e.g.  $O_2^-$ ) which can lead to oxidation of the metal<sup>45</sup> or degradation of ligands<sup>46</sup>. For Rh/Al<sub>2</sub>O<sub>3</sub>, the X-ray beam-induced reduction/agglomeration could have a similar mechanism involving secondary electrons. Rh is initially oxidized (RhO<sub>x</sub>), but in the presence of the X-ray beam the oxygen bound to RhO<sub>x</sub> is activated by secondary electrons. In a H<sub>2</sub> atmosphere the activated oxygen on the surface of RhO<sub>x</sub> reacts with H<sub>2</sub> resulting in reduction of Rh. The higher X-ray flux density at NSLS-II BL 08-ID compared with SSRL BL 4-1 will result in a higher number of secondary electrons and thus a faster reduction rate even at room temperature as seen in our work. Additionally, it is well known that addition of moisture accelerates mobility and the sintering of Rh/Al<sub>2</sub>O<sub>3</sub><sup>47</sup>. The activation of water molecules (water produced from the reduction of RhO<sub>x</sub>) and possibly neighboring hydroxyl groups on the support by secondary electrons could be the reason for the higher mobility of Rh and formation of larger clusters by the high flux density at NSLS-II BL 08-ID. This proposed mechanism is consistent with the stability of Rh in the beam in an O<sub>2</sub> atmosphere. In the event of activation of O in RhO<sub>x</sub> by secondary electrons, the presence of O<sub>2</sub> in the gas phase will likely re-oxidize Rh and keep it dispersed as RhO<sub>x</sub>, consistent with our results in O<sub>2</sub> atmosphere.

Our work shows that X-ray beam induced changes to heterogeneous catalysts might be more common, especially during *in-situ/operando* experiments. Furthermore, the results illustrate the importance and need for determining whether the X-ray beam influences the measured XAS data before reporting the results. We fully acknowledge the time pressures of performing experiments at a synchrotron, where a researcher typically only gains access for a few days every few months. However, our work reported here makes it clear that it is critical to take the time necessary to ensure that the reported data are not impacted by the measurement itself. At a minimum, we recommend that all heterogeneous catalyst samples, especially those measured *in-situ* and/or *operando*, be tested for beam effects by moving the beam to a different spot (see for example Figures S8 and S9). To avoid areas in the sample where the scattered beam would have generated secondary electrons and possibly resulted in beam damage, we estimate that a distance of 1-2 beam sizes would be needed between the new and previous spots. Furthermore, our results and other recent work<sup>19</sup> show the importance of minimizing the exposure time of heterogeneous catalysts to high flux density X-rays. The results highlight the need for fast, hard shutters, more sensitive/faster detectors and methods for minimizing background signal other than the metal of interest to minimize the X-ray dose on the catalyst. We anticipate that improved detection will not only allow higher flux beamlines to be used for lower concentration samples and detection of fast structural changes during *in-situ/operando* experiments without causing beam damage, it will also enable the use of low X-ray flux density beamlines for a larger range of *in-situ/operando* experiments.

## CONCLUSIONS

We investigated the effect of X-ray flux density on the structure of a Rh/Al<sub>2</sub>O<sub>3</sub> catalyst consisting of highly dispersed Rh. Our results show that higher X-ray flux density can cause reduction of Rh at room temperature and significant agglomeration of Rh during the *in-situ* reduction. The

agglomeration caused by exposure to the high flux density X-rays during reduction at 310 °C was similar to increasing the reduction temperature to 650 °C without exposure to the beam. Similar beam effects were observed for Ni/beta zeolite at an intermediate flux density beamline, indicating that beam damage is likely more common and the flux threshold needed is metal/support dependent. The results indicate that experiments at high flux beamlines need to be carefully designed to detect and mitigate beam damage that could adversely affect the structure of the catalyst. Additionally, the results indicate that improving detection to limit exposure to the beam is crucial for long duration *in-situ/operando* experiments at intermediate/high flux density beamlines, even for less sensitive catalyst samples.

## ASSOCIATED CONTENT

Additional Figures and Tables for XANES, EXAFS and model fits are provided in the supporting information.

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## TOC Graphic

